

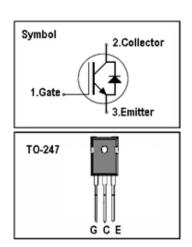
### **IGBT**

### **Features**

- 650V,40A
- $V_{CE(sat)(typ.)}=1.8V@V_{GE}=15V,I_{C}=40A$
- High speed switching
- Higher system efficiency
- Soft current turn-off waveforms
- Square RBSOA



JIAEN FS IGBTs offer lower losses and higher energy efficiency for application such as IH (induction heating), UPS, general inverter and other soft switching applications.



## **Absolute Maximum Ratings**

Symbol	Parameter	Value	Units
Vces	Collector-Emitter Voltage	650	V
V <sub>GES</sub>	Gate-Emitter Voltage ± 30		V
ı	Continuous Collector Current ( Tc=25 °C)	80	Α
lc	Continuous Collector Current (Tc=100°C)	40	Α
Ісм	Pulsed Collector Current (Note 1) 120		Α
I <sub>F</sub>	I <sub>F</sub> Diode Continuous Forward Current ( T <sub>C</sub> =100 ℃)		А
I <sub>FM</sub>	Diode Maximum Forward Current (Note 1) 120		Α
t <sub>sc</sub>	Short Circuit Withstand Time	5	us
Б	Maximum Power Dissipation ( T <sub>C</sub> =25 ℃)	246	W
P <sub>D</sub>	Maximum Power Dissipation ( T <sub>C</sub> =100℃)	123	W
TJ	Operating Junction Temperature Range	-45 to +175	°C
T <sub>STG</sub>	Storage Temperature Range	-55 to +150 ℃	

### **Thermal Characteristics**

Symbol	Parameter	Max.	Units	
R <sub>th j-c</sub>	j-c Thermal Resistance, Junction to case for IGBT 0.61		°C/W	
R <sub>th j-c</sub>	R <sub>th j-c</sub> Thermal Resistance, Junction to case for Diode		°C/W	
R <sub>th j-a</sub>	R <sub>th j-a</sub> Thermal Resistance, Junction to Ambient		°C/W	



## **Electrical Characteristics** (Tc=25 °C unless otherwise noted )

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
BV <sub>CES</sub>	Collector-Emitter Breakdown Voltage	$V_{GE}$ = 0V, $I_{C}$ = 250uA	650	-	-	V
I <sub>CES</sub>	Collector-Emitter Leakage Current	V <sub>CE</sub> = 650V, V <sub>GE</sub> = 0V	-	-	100	uA
I <sub>GES</sub>	Gate Leakage Current, Forward	$V_{GE} = \pm 20V, V_{CE} = 0V$	-	-	<u>+</u> 100	nA
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 250uA$	4.5	-	6.3	V
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	V <sub>GE</sub> =15V, I <sub>C</sub> = 40A	-	1.8	2.35	V
Qg	Total Gate Charge	Vcc=480V	-	82		nC
Qge	Gate-Emitter Charge	V <sub>GE</sub> =15V	-	14.3		nC
Qgc	Gate-Collector Charge	Ic=40A	-	45		nC
t d(on)	Turn-on Delay Time	Vcc=400V	-	36	-	ns
t r	Turn-on Rise Time		-	66	-	ns
t d(off)	Turn-off Delay Time	V <sub>GE</sub> =15V	-	137	-	ns
t f	Turn-off Fall Time	∃l <sub>C</sub> =40A _R <sub>G</sub> =15Ω	-	35	-	ns
Eon	Turn-on Switching Loss	Inductive Load	-	1.4	-	mJ
Eoff	Turn-off Switching Loss	T <sub>C</sub> =25 ℃	-	0.5	-	mJ
Ets	Total Switching Loss		-	1.9	-	mJ
C <sub>ies</sub>	Input Capacitance	V <sub>CE</sub> =25V V <sub>GE</sub> =0V	-	2020	-	pF
Coes	Output Capacitance		-	101	-	pF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1MHz	-	36	-	pF

# **Electrical Characteristics of Diode** (Tc=25°C unless otherwise noted)

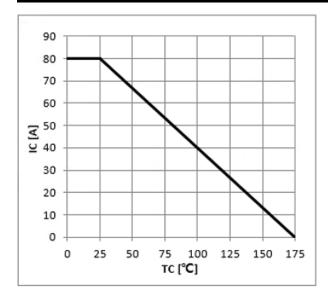
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> =40A	-	1.8	2.45	V
trr	Diode Reverse Recovery Time	V <sub>CE</sub> = 400V	-	180		ns
Irr	Diode peak Reverse Recovery Current	I <sub>F</sub> = 40A	-	17.5		Α
Qrr	Diode Reverse Recovery Charge	Rg=30 Ω	-	1106		nC

#### Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature



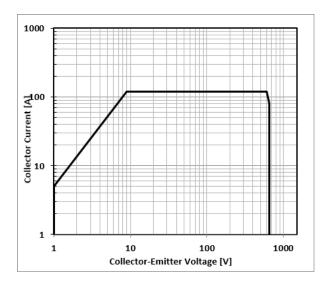
## **Typical Performance Characteristics**



300 250 Power Disspation pd [W] 200 150 100 50 0 25 50 75 100 125 150 175 TC [°C]

Figure 1: Maximum DC Collector Current VS. case temprature

Figure 2: Power Dissipation VS. Case Temperature



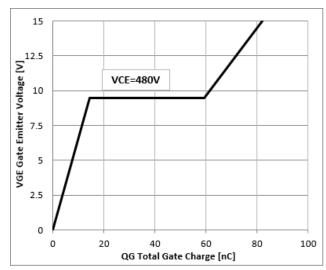
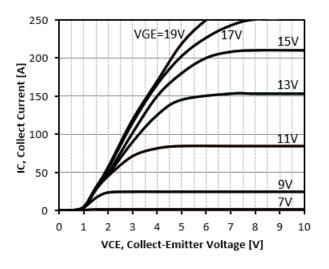


Figure 3: Reverse Bias SOA,TJ=125  $^{\circ}$ C,VGE=15V

Figure 4: Typical Gate charge VS. VGE,IC=40A



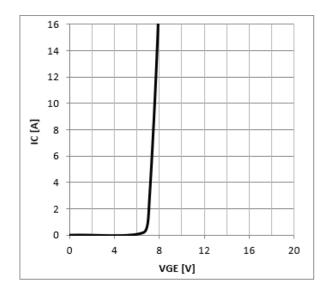




250 VGE=19V 200 IC, Collect Current [A] 15V 150 13V 100 110 9V 50 7V 0 1 9 10 VCE, Collect-Emitter Voltage [V]

Figure 5: Typical IGBT Output characteristics,  $\label{eq:TC=25\,C;tp=300us} TC = 25\,^{\circ}C; tp = 300us$ 

Figure 6: Typical IGBT Output characteristics,  $C = 150\,^{\circ}\!\text{C}; tp = 300 us$ 



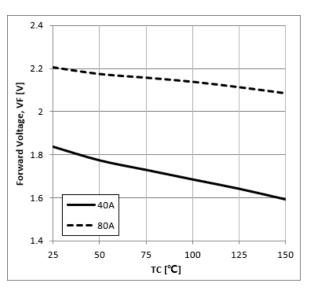


Figure 7: Typical Gate Threshold Voltage

Figure 8: Typical Forward Voltage vs IF



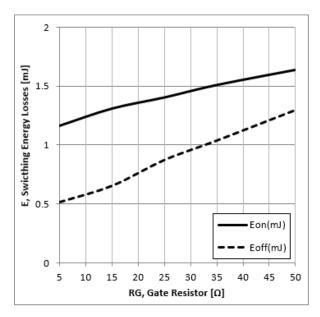


Figure 9: Typical Energy Loss VS. RG, TC=25 °C, L=100uH,VCE=400V,VGE=15V,IC=40A

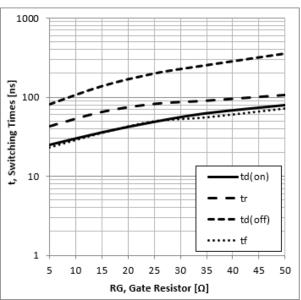


Figure 10: Typical Switching Time VS. RG, TC=25°C, L=100uH,VCE=400V,VGE=15V,IC=40A

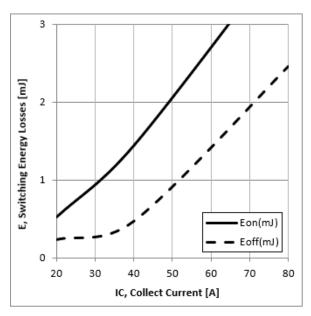


Figure 11: Typical Energy Loss VS. IC,TC=25 $^{\circ}$ C, L=100uH, VCE=400V, VGE=15V,RG=15 $^{\Omega}$ 

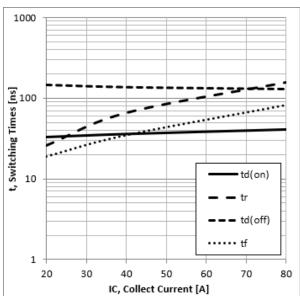


Figure 12: Typical Switching Time VS. IC,TC=25  $^{\circ}$ C, L=100uH,VCE=400V,VGE=15V,RG=15  $^{\Omega}$ 



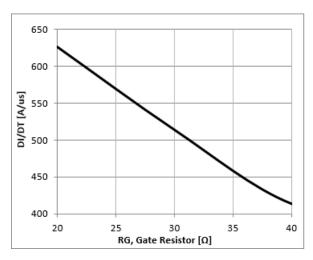


Figure 13: Typical Diode DI/DT VS. RG,TC=25℃ VCC=400V, VGE=15V, IF=40A

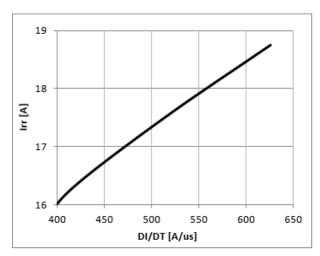


Figure 14: Typical Diode IRR VS. DI/DT,TC=25°C VCC=400V,VGE=15V, IF=40A

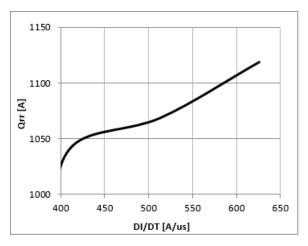


Figure 15: Typical Diode Qrr VS. DI/DT,TC=25℃ VCC=400V, VGE=15V, IF=40A

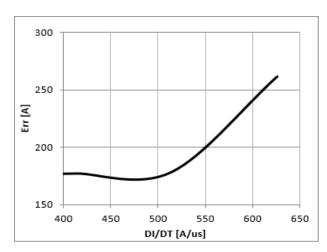


Figure 16: Typical Diode Err VS. DI/DT,TC=25℃ VCC=400V, VGE=15V, IF=40A



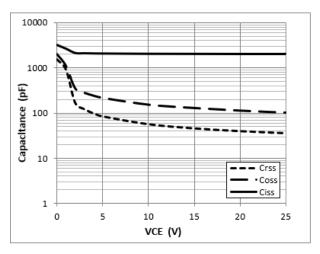


Figure 17: Typical Capacitance VS. VCE, VGE=0V,f=1MHz

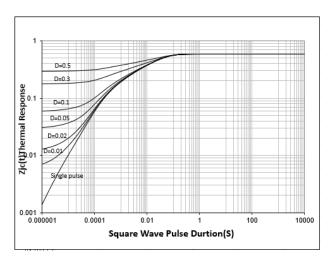
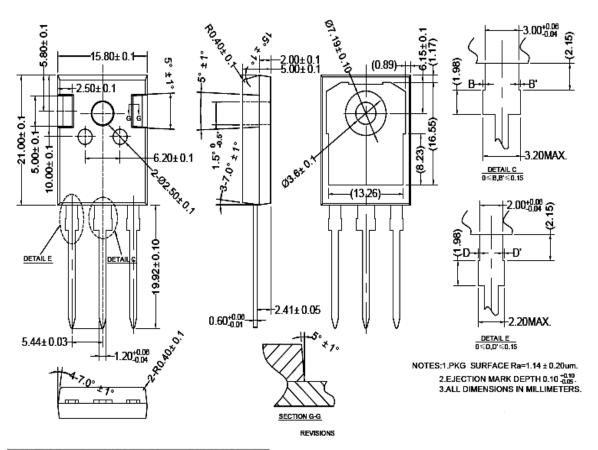


Figure 18: Normalized transient thermal impedance junction-to-case



### **TO247 PACKAGE OUTLINE**



公差标注	会差值	表面粗糙度
0	±0.2	Ra3.2~6.3
0.0	±0.1	Ra1.6~3.2
0.00	±0.01	Ra0.8~1.6
0.000	±0.005	Ra0.4~0.8
0.0000	±0.002	Ra0.2~0.4

0≤D,D'≤0.15

NOTES:1.PKG SURFACE Ra=1.14 ± 0.20um. 2.EJECTION MARK DEPTH 0.10 +0.10 3.ALL DIMENSIONS IN MILLIMETERS.



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